



上海双岭电子有限公司

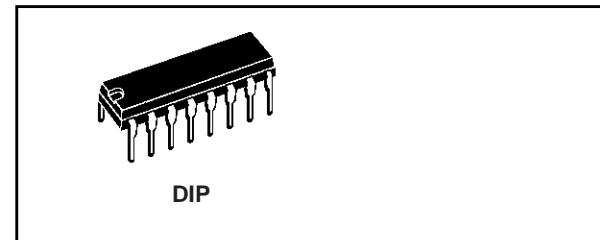
CC4555

## DUAL BINARY TO 1 OF 4 DECODER/DEMULTIPLEXER OUTPUT HIGH ON SELECT

- EXPANDABLE WITH MULTIPLE PACKAGES
- STANDARDIZED SYMMETRICAL OUTPUT CHARACTERISTICS
- QUIESCENT CURRENT SPECIFIED UP TO 20V
- 5V, 10V AND 15V PARAMETRIC RATINGS
- INPUT LEAKAGE CURRENT  
 $I_I = 100\text{nA}$  (MAX) AT  $V_{DD} = 18\text{V}$   $T_A = 25^\circ\text{C}$
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC JESD13B "STANDARD SPECIFICATIONS FOR DESCRIPTION OF B SERIES CMOS DEVICES"

### DESCRIPTION

The CC4555 is a monolithic integrated circuit fabricated in Metal Oxide Semiconductor technology available in DIP and SOP packages. The CC4555 is a dual 1 of 4 decoder/demultiplexer. Each decoder has two select inputs (A and B), an Enable input ( $\bar{E}$ ), and four mutually

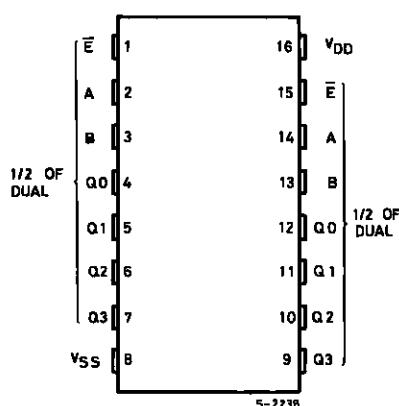


### ORDER CODES

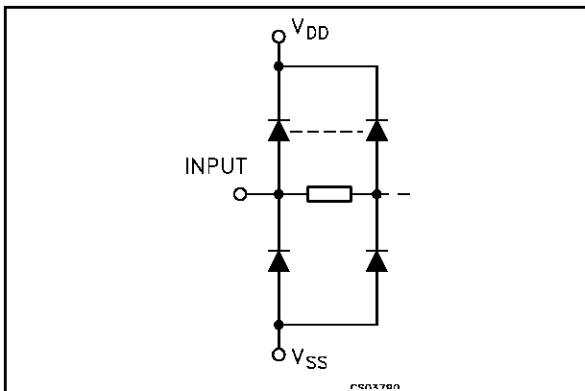
PACKAGE	TUBE	T & R
DIP	CC4555	

exclusive outputs. On the CC4555 the outputs are high on select. When the Enable input is high, the outputs are low regardless of the state of the select inputs A and B.

### PIN CONNECTION



## INPUT EQUIVALENT CIRCUIT



## PIN DESCRIPTION

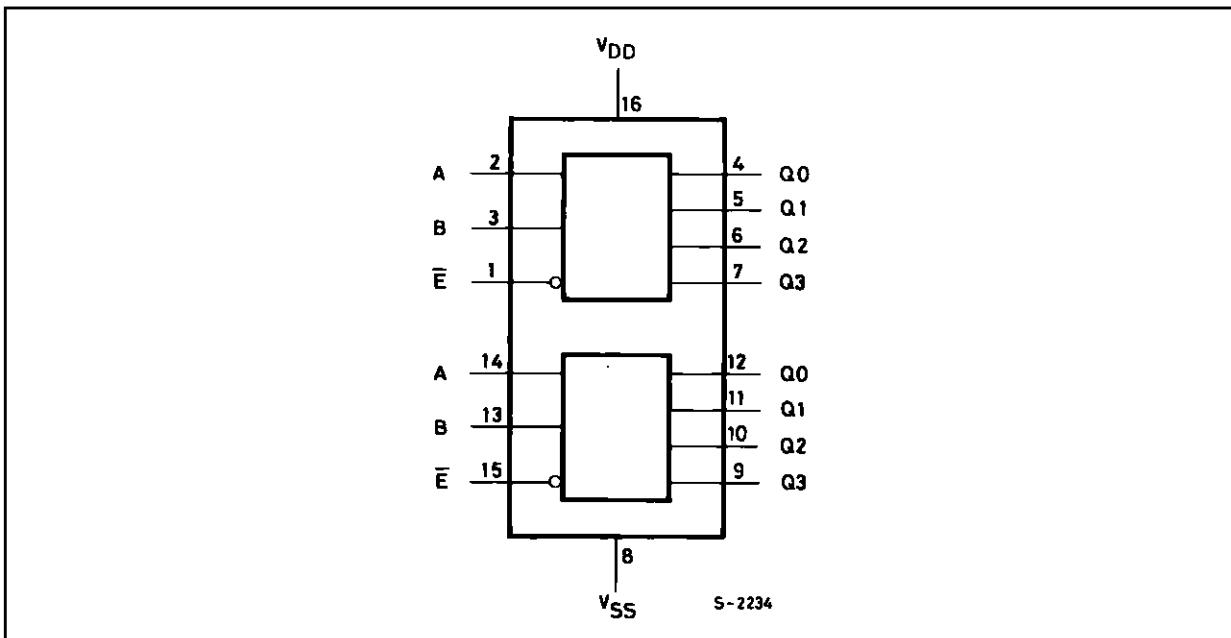
PIN No	SYMBOL	NAME AND FUNCTION
2, 3	A, B	Select Inputs (1/2 of dual)
1	$\bar{E}$	Enable Input (1/2 of dual)
4, 5, 6, 7	Q0 to Q3	Outputs (1/2 of dual)
14, 13	A, B	Select Inputs (1/2 of dual)
15	$\bar{E}$	Enable Input (1/2 of dual)
12, 11, 10, 9	Q0 to Q3	Outputs (1/2 of dual)
8	$V_{SS}$	Negative Supply Voltage
16	$V_{DD}$	Positive Supply Voltage

## TRUTH TABLE

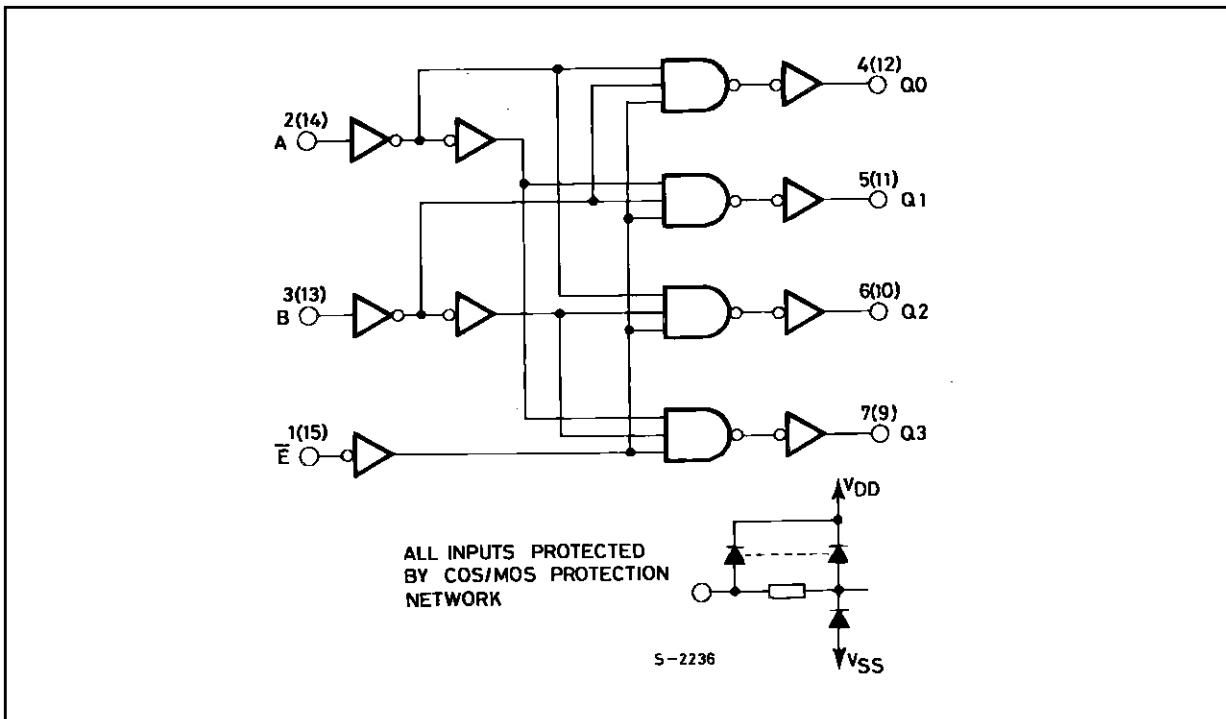
INPUTS ENABLE SELECT			OUTPUTS			
$\bar{E}$	B	A	Q3	Q2	Q1	Q0
L	L	L	L	L	L	H
L	L	H	L	L	H	L
L	H	L	L	H	L	L
L	H	H	H	L	L	L
H	X	X	L	L	L	L

X : Don't Care

## FUNCTIONAL DIAGRAM



## LOGIC DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$V_{DD}$	Supply Voltage	-0.5 to +20	V
$V_I$	DC Input Voltage	-0.5 to $V_{DD} + 0.5$	V
$I_I$	DC Input Current	$\pm 10$	mA
$P_D$	Power Dissipation per Package	200	mW
	Power Dissipation per Output Transistor	100	mW
$T_{op}$	Operating Temperature	-55 to +125	°C
$T_{stg}$	Storage Temperature	-65 to +150	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.

All voltage values are referred to  $V_{SS}$  pin voltage.

## RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
$V_{DD}$	Supply Voltage	3 to 18	V
$V_I$	Input Voltage	0 to $V_{DD}$	V
$T_{op}$	Operating Temperature	-55 to 125	°C

## DC SPECIFICATIONS

Symbol	Parameter	Test Condition				Value						Unit	
		$V_I$ (V)	$V_O$ (V)	$I_{IO}$ ( $\mu$ A)	$V_{DD}$ (V)	$T_A = 25^\circ C$			$-40 \text{ to } 85^\circ C$		$-55 \text{ to } 125^\circ C$		
						Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
$I_L$	Quiescent Current	0/5			5		0.04	5		150		150	$\mu A$
		0/10			10		0.04	10		300		300	
		0/15			15		0.04	20		600		600	
		0/18			18		0.08	100		3000		3000	
$V_{OH}$	High Level Output Voltage	0/5		<1	5	4.95			4.95		4.95		V
		0/10		<1	10	9.95			9.95		9.95		
		0/15		<1	15	14.95			14.95		14.95		
$V_{OL}$	Low Level Output Voltage	5/0		<1	5		0.05			0.05		0.05	V
		10/0		<1	10		0.05			0.05		0.05	
		15/0		<1	15		0.05			0.05		0.05	
$V_{IH}$	High Level Input Voltage		0.5/4.5	<1	5	3.5			3.5		3.5		V
			1/9	<1	10	7			7		7		
			1.5/13.5	<1	15	11			11		11		
$V_{IL}$	Low Level Input Voltage		4.5/0.5	<1	5			1.5		1.5		1.5	V
			9/1	<1	10			3		3		3	
			13.5/1.5	<1	15			4		4		4	
$I_{OH}$	Output Drive Current	0/5	2.5	<1	5	-1.36	-3.2		-1.1		-1.1		mA
		0/5	4.6	<1	5	-0.44	-1		-0.36		-0.36		
		0/10	9.5	<1	10	-1.1	-2.6		-0.9		-0.9		
		0/15	13.5	<1	15	-3.0	-6.8		-2.4		-2.4		
$I_{OL}$	Output Sink Current	0/5	0.4	<1	5	0.44	1		0.36		0.36		mA
		0/10	0.5	<1	10	1.1	2.6		0.9		0.9		
		0/15	1.5	<1	15	3.0	6.8		2.4		2.4		
$I_I$	Input Leakage Current	0/18	Any Input	18			$\pm 10^{-5}$	$\pm 0.1$		$\pm 1$		$\pm 1$	$\mu A$
$C_I$	Input Capacitance		Any Input			5	7.5						pF

The Noise Margin for both "1" and "0" level is: 1V min. with  $V_{DD}=5V$ , 2V min. with  $V_{DD}=10V$ , 2.5V min. with  $V_{DD}=15V$

DYNAMIC ELECTRICAL CHARACTERISTICS ( $T_{amb} = 25^\circ C$ ,  $C_L = 50pF$ ,  $R_L = 200K\Omega$ ,  $t_r = t_f = 20 \text{ ns}$ )

Symbol	Parameter	Test Condition				Value (*)			Unit
		$V_{DD}$ (V)				Min.	Typ.	Max.	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time	5	A or B Input to any Output				220	440	ns
		10					95	190	
		15					70	140	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time	5	$\overline{E}$ Input to any Output				200	400	ns
		10					85	170	
		15					65	130	
$t_{TLH}$ $t_{THL}$	Transition Time	5					100	200	ns
		10					50	100	
		15					40	80	

(\*) Typical temperature coefficient for all  $V_{DD}$  value is 0.3 %/ $^\circ C$ .